

FDR8305N

Dual N-Channel 2.5V Specified PowerTrench® MOSFET

General Description

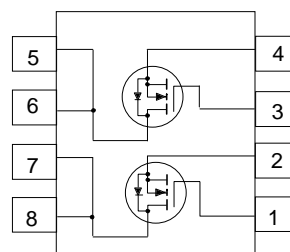
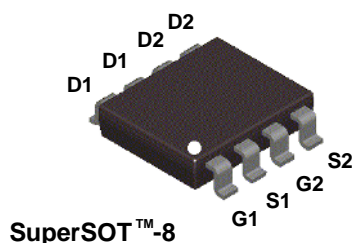
These N-Channel 2.5V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

Applications

- Load switch
- Motor driving
- Power Management

Features

- 4.5 A, 20 V. $R_{DS(ON)} = 0.022 \Omega @ V_{GS} = 4.5 \text{ V}$
 $R_{DS(ON)} = 0.028 \Omega @ V_{GS} = 2.5 \text{ V}$.
- Low gate charge (16.2nC typical).
- Fast switching speed.
- High performance trench technology for extremely low $R_{DS(ON)}$.
- Small footprint (38% smaller than a standard SO-8); low profile package (1 mm thick); power handling capability similar to SO-8.



Absolute Maximum Ratings T_A = 25°C unless otherwise noted

| Symbol | Parameter | Ratings | Units |
|-----------------------------------|--|-------------|-------|
| V _{DSS} | Drain-Source Voltage | 20 | V |
| V _{GSS} | Gate-Source Voltage | ±8 | V |
| I _D | Drain Current - Continuous (Note 1a) | 4.5 | A |
| | - Pulsed | 20 | |
| P _D | Power Dissipation for Single Operation (Note 1a) | 0.8 | W |
| T _J , T _{stg} | Operating and Storage Junction Temperature Range | -55 to +150 | °C |

Thermal Characteristics

| | | | |
|------------------|---|-----|------|
| R _{θJA} | Thermal Resistance, Junction-to-Ambient (Note 1a) | 156 | °C/W |
| R _{θJC} | Thermal Resistance, Junction-to-Case (Note 1) | 40 | °C/W |

Package Marking and Ordering Information

| Device Marking | Device | Reel Size | Tape Width | Quantity |
|----------------|----------|-----------|------------|------------|
| .8305 | FDR8305N | 13" | 12mm | 3000 units |

Electrical Characteristics

$T_A = 25^\circ\text{C}$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

Off Characteristics

| | | | | | | |
|--------------------------------------|---|---|----|----|------|----------------------------|
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$ | 20 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$, Referenced to 25°C | | 14 | | $\text{mV}/^\circ\text{C}$ |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 16\text{ V}, V_{GS} = 0\text{ V}$ | | | 1 | μA |
| I_{GSSF} | Gate-Body Leakage Current, Forward | $V_{GS} = 8\text{ V}, V_{DS} = 0\text{ V}$ | | | 100 | nA |
| I_{GSSR} | Gate-Body Leakage Current, Reverse | $V_{GS} = -8\text{ V}, V_{DS} = 0\text{ V}$ | | | -100 | nA |

On Characteristics (Note 2)

| | | | | | | |
|--|--|--|-----|-------------------------|-------------------------|----------------------------|
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$ | 0.4 | 0.85 | 1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D = 250\ \mu\text{A}$, Referenced to 25°C | | -3 | | $\text{mV}/^\circ\text{C}$ |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 4.5\text{ V}, I_D = 4.5\text{ A}$ $V_{GS}=4.5\text{ V}, I_D=4.5\text{ A}, T_J=125^\circ\text{C}$ $V_{GS} = 2.5\text{ V}, I_D = 4\text{ A}$ | | 0.015 0.026 0.020 | 0.022 0.040 0.028 | Ω |
| $I_{D(on)}$ | On-State Drain Current | $V_{GS} = 4.5\text{ V}, V_{DS} = 5\text{ V}$ | 10 | | | A |
| g_{FS} | Forward Transconductance | $V_{DS} = 4.5\text{ V}, I_D = 4.5\text{ A}$ | | 24 | | S |

Dynamic Characteristics

| | | | | | | |
|-----------|------------------------------|--|--|------|--|----|
| C_{iss} | Input Capacitance | $V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$ | | 1600 | | pF |
| C_{oss} | Output Capacitance | | | 380 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 200 | | pF |

Switching Characteristics (Note 2)

| | | | | | | |
|--------------|---------------------|---|--|------|----|----|
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 10\text{ V}, I_D = 1\text{ A},$ $V_{GS} = 4.5\text{ V}, R_{GEN} = 6\ \Omega$ | | 12 | 22 | ns |
| t_r | Turn-On Rise Time | | | 15 | 27 | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | | 35 | 55 | ns |
| t_f | Turn-Off Fall Time | | | 18 | 30 | ns |
| Q_g | Total Gate Charge | $V_{DS} = 10\text{ V}, I_D = 4.5\text{ A},$ $V_{GS} = 4.5\text{ V}$ | | 16.2 | 23 | nC |
| Q_{gs} | Gate-Source Charge | | | 2.5 | | nC |
| Q_{gd} | Gate-Drain Charge | | | 5.5 | | nC |

Drain-Source Diode Characteristics and Maximum Ratings

| | | | | | | |
|----------|---|---|--|------|-----|---|
| I_S | Maximum Continuous Drain-Source Diode Forward Current | | | 0.67 | | A |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0\text{ V}, I_S = 0.67\text{ A}$ (Note 2) | | 0.65 | 1.2 | V |

Notes:

- $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design. Both devices are assumed to be operating and sharing the dissipated heat energy equally.



$156^\circ\text{C}/\text{W}$ on a minimum mounting pad of 2oz copper.

Scale 1 : 1 on letter size paper

- Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2.0\%$.

Typical Characteristics

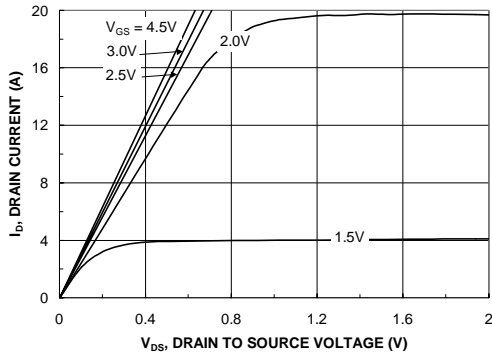


Figure 1. On-Region Characteristics.

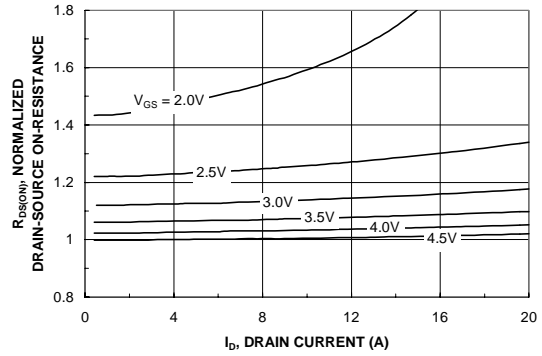


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

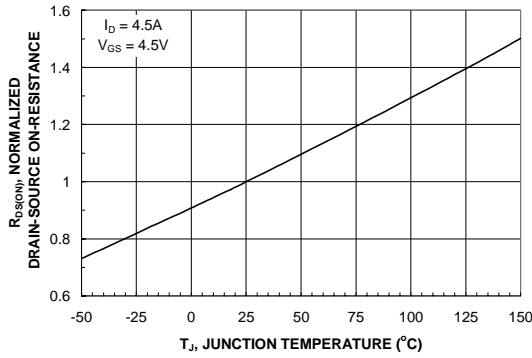


Figure 3. On-Resistance Variation with Temperature.

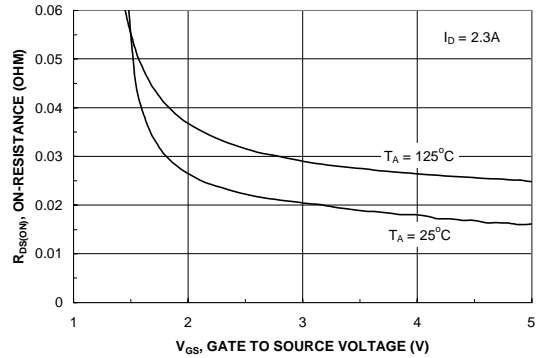


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

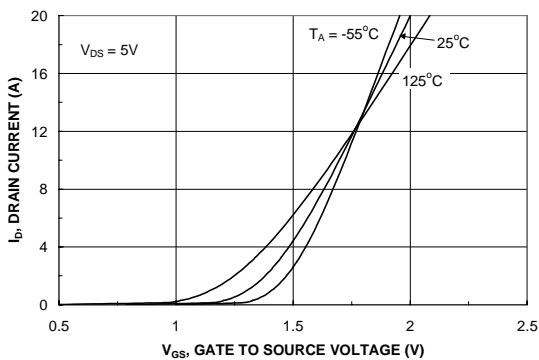


Figure 5. Transfer Characteristics.

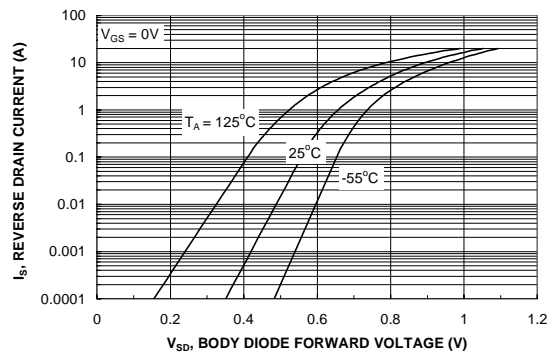


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics (continued)

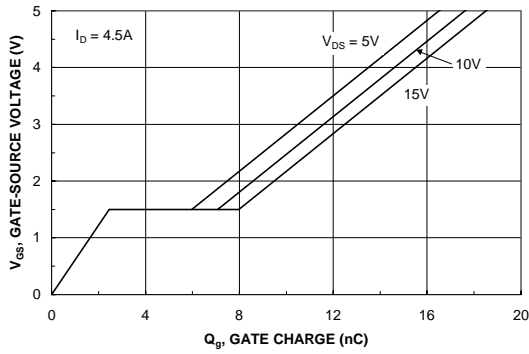


Figure 7. Gate Charge Characteristics.

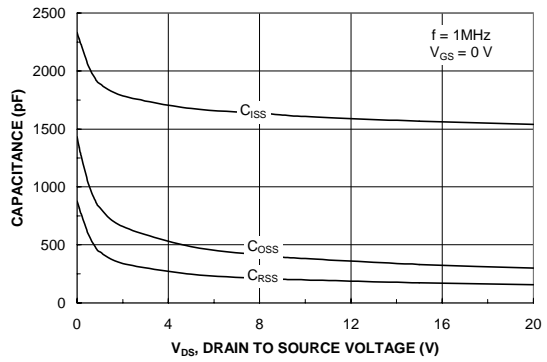


Figure 8. Capacitance Characteristics.

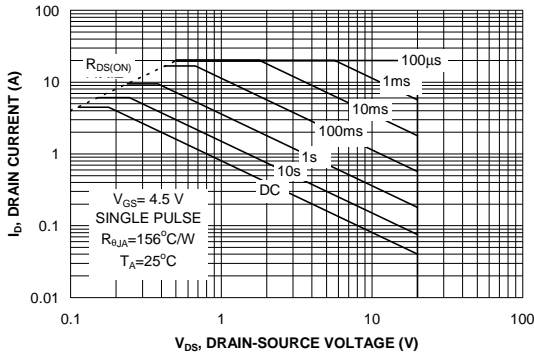


Figure 9. Maximum Safe Operating Area.

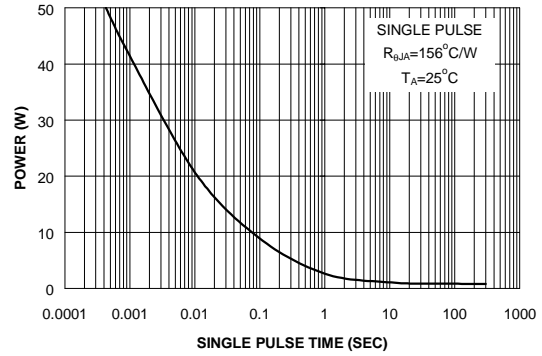
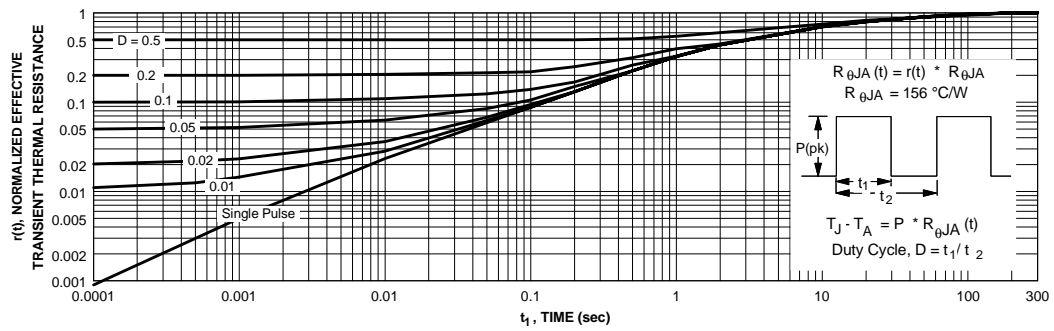


Figure 10. Single Pulse Maximum Power Dissipation.



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| FACT Quiet Series™ | QS™ | |
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